S	Searc	earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/929,742	TESCH ET AL.	
Examiner	Art Unit	
Paul Nguyen-Ba	2176	

SEARCHED				
Class	Subclass	Date	Examiner	
***	Updated Previous Search	8/2/2006	PNB	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
DATE	EXMR		
8/2/2006	PNB		
8/2/2006	PNB		
	DATE 8/2/2006		